Tracking of Triangular References Using Signal Transformation for Control of a Novel AFM Scanner Stage

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Abstract—In this paper, we design feedback controllers for lateral and transversal axes of an atomic force microscope (AFM) piezoelectric tube scanner. The controllers are constrained to keep the standard deviation of the measurement noise fed back to the displacement output around 0.13 nm. It is shown that the incorporation of appropriate inner loops provides disturbance rejection capabilities and robustness against dc gain uncertainties, two requirements for satisfactory operation of signal transformation method. Simulations and experiments show significant improvement of steady-state tracking error with signal transformation, while limiting the projected measurement noise.

Index Terms—Closed-loop bandwidth, measurement noise, robustification, scanning probe microscopy, sensor fusion, signal transformation, switched control, triangular reference.

I. INTRODUCTION

OBSEVATION, control, and manipulation of matter at very small dimensions have attracted a great amount of attention in nanotechnology [1], [2]. The invention of scanning probe microscopy (SPM) is one of the revolutionary events in nanoscience and nanotechnology [3]–[5]. SPMs promise breakthroughs in areas such as nanometrology [6]–[9], nanolithography [10], [11], material science [12], [13], high-density data storage systems [14]–[16], and nano-fabrication [17]. SPMs are capable of generating 3-D maps of material surfaces on an atomic scale.

Piezoelectric tube scanners are the most commonly used mechanism in commercial AFM to position a sample close to the cantilever probe and to move the sample in a raster pattern during scanning [18], [19]. The tube is fixed at one end and free at the other. Due to the large length-to-diameter ratio of the piezoelectric tube scanner, the free end of the tube experiences a relatively low mechanical resonance frequency. This makes the tube susceptible to scan-induced vibration. During raster scanning, a triangular waveform is applied to the fast axis (z-axis) and a staircase or ramp signal is applied to the slow axis (x-axis) of the piezoelectric tube scanner. The triangular waveform contains all odd harmonics of the fundamental frequency. The high-frequency content in a fast triangular waveform can excite the tube’s resonance and subsequently distort the scanned image.

Accurate tracking of a fast triangular waveform is one of the major challenges not only in SPM [19]–[29] but also in other scanner-based devices such as optical scanners and selective laser sintering (SLS) machines [30], [31]. The performance of the piezoelectric tube scanner is often quantified by its positioning resolution (which is governed by measurement noise), tracking bandwidth and robustness to disturbances [5]. There has been a significant effort to improve the tracking accuracy and speed of piezoelectric tube scanners using feedback control techniques. To track a fast triangular signal, high-bandwidth closed-loop controllers have been implemented in many nanopositioning devices [19], [23], [24], [26], [28], [32]–[34]. However, the scanning speed is limited in feedback control systems due to hysteresis, thermal drift, sensor noise, uncertainty, and mechanical vibrations when piezoelectric tubes are used to follow non-smooth triangular trajectories [18]. Capacitive and inductive sensors are commonly used in nanopositioning systems due to their capability of providing simple solution for non-contact, high-resolution measurement. These sensors typically have a noise density of 20 pm/√Hz [26]. For every hundredfold increment in the closed-loop system bandwidth, the position accuracy of a nanopositioning scanner will decrease tenfold. This potentially degrades the resolution of the scanner, hindering it from performing positioning tasks that require sub-nanometer resolution. Hence, feedback control methods with limited closed-loop bandwidth are of considerable importance.

Command pre-shaping methods can be considered as a possible way for vibration suppression in an already designed closed-loop control system, leaving the closed-loop bandwidth of the measurement noise unaffected [35]–[44]. However, these methods are not suitable for tracking of time-varying commands such as triangular waveforms or suffer from lack of robustness to plant uncertainties. Iterative learning control (ILC) can also be added as a feed-forward control action in a feedback system to improve the steady-state tracking error for repetitive references without altering the closed-loop bandwidth.
However, it may require a large number of iterations to converge. Feedback control methods such as repetitive control (RC) for tracking of periodic references introduce large closed-loop bandwidths, which may not be acceptable in the presence of measurement noise. Moreover, the tradeoff between the tracking error and rejection of non-periodic disturbances in RC systems can cause problems when excessive cross coupling exist between the scanner axes [46], [47].

In [48], the concept of signal transformation was put forward as a novel approach for tracking of triangular waveforms in a nanopositioning system. The method showed significant closed-loop performance improvement compared with an ordinary feedback-control-system having a similar control bandwidth. However, the method is sensitive to DC gain variations and disturbances arising from cross coupling between the two axes.

This paper explains how signal transformation method can be used along with traditional feedback control methods to improve tracking error in an atomic force microscope (AFM) scanner while keeping closed-loop measurement noise below a pre-specified level and providing stability and robustness to DC-gain variations and disturbances.

II. OBJECTIVES

An objective of this paper is to evaluate the capability of the signal transformation method in reducing projected measurement noise compared to ordinary feedback systems. To do this, we maintain the standard deviation of the projected measurement noise around 0.13 nm at the actual displacement of $x$-axis. The other objective is to provide disturbance rejection capability and robustness when signal transformation is incorporated into the control systems.

III. SIGNAL TRANSFORMATION

Signal transformation approach incorporates appropriate mappings between non-smooth signals (e.g., triangular waveforms) and smooth signals (e.g., ramps) in a control system to improve the tracking error while keeping the closed-loop bandwidth low to limit the projected measurement noise [48]. The signal transformation method for control of a single-input–single-output (SISO) plant is described by the hybrid control system shown in Fig. 1, where $\Phi$ and $\Phi^{-1}$ refer to the signal transformation mappings, which in the case of triangular signal tracking use piecewise constant gains $g_1$ and $g_2$, as well as biases $b_1$ and $b_2$, as shown in Fig. 2 and can be presented in the following forms:

$$g_1 \equiv g_2 \equiv (-1)^k, \quad b_2 = 2a_0k, \quad b_1 = -(1)^k b_2$$  \hspace{1cm} (1)

where $a_0$ is the amplitude of the desired triangular waveform $x_d$, which has period $2T$, as shown in the left top insert in Fig. 1, and $k$ is the index of half period defined as

$$k(t) = \text{floor} \left( \frac{t}{T} + 0.5 \right).$$  \hspace{1cm} (2)

The signal transformation blocks, which use $g_2$ and $b_2$, can convert the non-smooth periodic triangular signal $x_d$ into a smooth ramp signal denoted by $r$ in the left top insert in Fig. 1. The signal transformation block between the plant and compensator does the reverse action, i.e., it converts the smooth ramp signal into a non-smooth triangular signal.

To understand how the method works, consider a steady-state ideal situation, where the noise $n$ and output disturbance $d_0$ are zero, the plant is a unity gain transfer function, and its output is
perfectly following the desired triangular signal. Also assume that the compensator contains at least two integrators for perfect tracking of ramp references. In this case, the mapping $\Phi$ acting on the plant output $x$ generates an output signal equal to the ramp reference signal $r$ such that the error signal $e$ vanishes after a transient. The double integral action converts the error signal to a ramp signal $v$ at the compensator’s output. The inverse mapping $\Phi^{-1}$ converts the smooth ramp signal $v$ to a non-smooth triangular actuation signal at $u$, which is required to generate a triangular signal at the plant output. Hence, the input/output signals at compensator block are smooth signals with no breaks or discontinuities and the burden of providing appropriate non-smooth trajectories at the actuator, which demands a high control bandwidth in an ordinary feedback system, is done by the signal transformation block. In this way, the compensator can be designed with a smaller closed-loop bandwidth in favor of rejecting the projected measurement noise without deteriorating the steady-state error. The signal transformation method, however, has robustness and disturbance rejection problems, which will be explained in Section IV.

IV. INVESTIGATION OF SYSTEM ROBUSTNESS

In this section, we use simulations to show that the signal transformation method mentioned in Section III can improve the tracking performance of feedback control systems with low closed-loop bandwidth, which translates into low projected noise. We also investigate robustness of the method to DC gain variations and output disturbances using a model obtained for the $x$-axis of an AFM scanner. To do this, we use a model for the $x$-axis of the scanner, obtained after closing a damping loop around a low noise piezoelectric strain-induced voltage sensor to damp the first resonance of the tube (see Section VI-C). The model has zeros at $230 \pm 6000i$, $-1180 \pm 876i$, and $-2,1$, and poles at $-1286 \pm 1990i$, $-1100 \pm 1497i$, and $-2,3$. A constant gain of $1/0.42$ was included at the input to force a unity dc gain for the plant in Fig. 1. The compensator in Fig. 1 is a double integrator plus an integrator in the following form:

$$K_x(s) = 2.3 \times \frac{50s + 250}{s^2}$$

which provides a gain margin of 23.4 dB, a phase margin of 87°, and reduces the closed-loop bandwidth to 21 Hz. Such a closed-loop bandwidth can keep the projected measurement noise around 0.13 nm, as shown in Section VI-D. For a 10 Hz triangular reference with amplitude $a_0 = 2$ V and under different conditions, the resulting closed-loop steady-state errors are shown in Fig. 3. With unity dc gain and no disturbances the signal transformation provides acceptable tracking (compare the thick solid line curve with a 4 V peak-to-peak triangular reference). However, when the plant dc gain is increased or is reduced twice (6 dB), which is much less than the gain margin, the error increases unacceptably, as shown in Fig. 3. This shows lack of robustness against variations in the plant dc gain.

The sensitivity of signal transformation method to plant dc gain variations is mainly due to the design of inverse mapping $\Phi^{-1}$, which generates the plant input $u$. To understand this, let the plant’s transfer function be a non-unity constant gain. For perfect tracking, the plant input signal, consistent with the reference, should be a triangular signal whose amplitude is different from $a_0$. However, the jumps in signal $q_1$ have been adjusted to convert a ramp signal to a triangular waveform with amplitude of $a_0$.

To evaluate the effect of output disturbances, we set the plant dc gain back to unity and applied a unity amplitude step signal at the exogenous input $d_0$ in Fig. 1 while the triangular reference set-point was applied. The resulting steady-state error, plotted in Fig. 3 with the dotted line, shows an undesirable disturbance rejection performance. In this example, the application of signal transformation together with a 21 Hz control bandwidth cannot achieve acceptable disturbance rejection. Although it is satisfactory for tracking in the absence of disturbances.

To compare the signal transformation method with a 1-degrees-of-freedom (DoF) controller having the same bandwidth, we replaced the signal transformation blocks by unity gains in Fig. 1. The resulting ordinary feedback system with unity plant dc gain and no disturbances has the response labeled “No signal transformation” in Fig. 3, which shows that the 21 Hz bandwidth without signal transformation is not enough for acceptable tracking of a 10 Hz triangular reference.

V. INCORPORATING ROBUSTNESS IN SIGNAL TRANSFORMATION

In this section, we incorporate an intermediate feedback loop prior to signal transformation blocks, as shown in Fig. 4, to improve the robustness properties mentioned in Section IV. In Fig. 4, the signal transformation mappings denoted by $\Phi$ and $\Phi^{-1}$ are as before, and variables $d_{ux}, v_{ux}, v_{px}, v_{ex}$ and $u_{ex}$ stand for output disturbance, measurement noise, capacitive sensor output, piezoelectric strain-induced voltage, and piezoelectric actuation voltage of the $x$-axis, respectively. A low-pass filter $F(s) = (1 + s/1000)^{-1}$ was used to reduce the effect of measurement noise. The intermediate and outer compensators were selected as

$$K_i(s) = \frac{166,667}{s} \quad (4)$$

$$K_u(s) = \frac{50s + 250}{s^2}.$$  

\(5\)
and has a low bandwidth of 21 Hz similar to Section IV. This transfer function, whose experimental frequency response is shown in Fig. 5, can be described as

\[ T_{xx}(s) = \frac{x(s)}{r_x(s)} = \frac{K_i(s)P_x(s)[F(s) + K_{ii}(s)]}{1 + K_i(s)P_x(s)[F(s) + K_{ii}(s)]} \]  

(6)

where \( P_x(s) \) is the transfer function of the damped system of \( x \)-axis, which can be described as

\[ P_x(s) = \frac{T_{cr}(s)}{1 + C_x(s)T_{cr}(s)} \]  

(7)

where \( T_{cr}(s) \) and \( T_{cr}(s) \) stand for the transfer functions from \( x \) actuation input voltage to the displacement and piezoelectric strain-induced output voltages of \( x \)-axis, respectively. The robustification loop by itself (excluding the outer loop) provides a unity dc gain form \( u \) to \( x \) with a gain margin of 27.7 dB, phase margin of 90°, and bandwidth of 13 Hz. The overall system has a gain margin of 42 dB, phase margin of 55°, and bandwidth of 11.6 Hz for the forward transfer function from the reference to the displacement output, which is also shown in Fig. 5 and described by the following relationship:

\[ T_{xr}(s) := \frac{x(s)}{r_x(s)} = \frac{K_i(s)P_x(s)[F(s) + K_{ii}(s)]}{1 + K_i(s)P_x(s)[F(s) + K_{ii}(s)]}, \]  

(8)

The simulation results shown in Fig. 6 correspond to closed-loop response of the proposed method where the same triangular reference signal and disturbance as in Section IV are used and the plant dc gain of the legends refers to the dc gain of the damped system in Fig. 4. Clearly, the steady-state tracking error remains acceptable in the presence of dc-gain variations of the plant and output disturbance, which shows that the robustification loop can improve the robustness issue of the signal transformation method without deteriorating its benefits (low tracking error with low bandwidth).

VI. EXPERIMENTS

In this section, signal transformation method with the proposed robustifying scheme is performed on the \( x \)-axis of the actual scanner for further examination.

A. Description of AFM Scanner

Fig. 7 shows the NT-MDT NTEGRA scanning probe microscope (SPM) was used to perform experiments reported here. The SPM is configured to operate as an AFM. A protective hood was used as a shield against acoustic noise, electromagnetic fields, and temperature variations. As shown in Fig. 8, the original scanner of the SPM was replaced by a 12-electrode piezoelectric tube scanner [49] which is used for simultaneous sensing and actuation.

External electrode of the piezoelectric tube scanner is segmented into 12 equal sections, as shown in Fig. 9, and the inner electrode is a continuous electrode which is grounded. It has a small continuous electrode at the top of the tube for \( z \)-axis actuation. One end of the tube is fixed. The free end serves as a stage over which a sample can be placed and its horizontal deflections are measured by two capacitive sensors. Fig. 10 illustrates the wiring of the tube for actuation and sensing in the \( x \)-axis alone, where \( \theta_{px} \) and \( \theta_{px} \) are actuation and piezoelectric strain-induced voltages after and before amplification, respectively. The same wiring is applied to the \( y \)-axis and is not illustrated for brevity sake. The two outer electrodes on opposite sides are
Fig. 7. NT-MDT NTEGRA SPM. The tube scanner is located below the scanning head.

Fig. 8. Tube scanner is installed into the SPM. The two capacitive sensors are mounted at right angles to the target.

Fig. 9. Segmentation of the electrodes on the piezoelectric tube (dimensions in millimeter).

used for actuation. When voltages with equal magnitudes but opposite polarities ($\pm U_p$) are applied to these electrodes, one side of the tube extends and the opposite side retracts, resulting in bending and top displacement $d_y$. The displacement is measured by the voltage signal $V_{cp}$ using a capacitive sensor, whose projected noise is to be kept below a certain level in the feedback systems considered in this paper. The strain experienced on each side of the tube is translated into a voltage at the respective central electrode due to the piezoelectric effect. Due to the symmetry, the voltages induced at the two central electrodes are equal in magnitude but 180° out of phase. The voltage induced in one electrode is inverted and added to that obtained from the opposite electrode. The resulting signal $V_{cp}$, whose noise is negligible, will be used as an auxiliary output in a high bandwidth loop to damp the first resonance of the tube. Actuation and sensing in the $y$-direction can be obtained in a similar manner. For $z$-axis actuation, a voltage is applied to the continuous electrode ($z$-electrode) near the free end of the tube.

Piezoelectric strain-induced voltages have a first-order high-pass characteristic at low frequencies. This is due to the capacitive nature of the piezoelectric tube and finite input impedance of a measurement device [50]. The transfer function of the strain-induced voltage to the output of a voltage measuring instrument resembles a first-order high-pass filter. To minimize the cutoff frequency of the high-pass filter, piezoelectric strain-induced voltages were fed to low noise preamplifiers (Stanford Research Systems SR560). The input impedance of the preamplifier is 100 MΩ. The measured capacitance of each sensing electrode is 3.2 nF. Together with the input impedance of the preamplifier, the cutoff frequency of the high-pass filter is reduced to 0.5 Hz. Although the cutoff frequency is low, accurate positioning at low frequencies using the strain-induced voltage alone could be difficult [19].

Piezoelectric strain-induced voltage has a very low noise profile at high frequencies [19], [26]. The noise density of the strain voltage was reported in [26] to be 16 fm/√Hz, which is a thousand times smaller than that of a typical capacitive sensor. Therefore, the strain-induced voltage is a preferred choice of sensor for damping resonances of the piezoelectric tube that occurs at high frequencies. Two capacitive sensors,
which provide displacement measurement, are used for implementation of the horizontal position feedback. As shown in Fig. 8, these capacitive sensors were placed in close proximity to the adjacent surfaces of the sample holder to measure the displacement of the tube scanner along the $x$- and $y$-axes.

The $x$- and $y$-axes of the piezoelectric tube were driven by a NANONIS bipolar high voltage amplifier HVA4. The amplifier has a voltage range of $\pm 400$ V. A dSPACE-1103 rapid prototyping system was used to implement the $x$- and $y$-axes feedback controllers in real-time. The $z$-axis displacement was controlled using the AFM’s software and circuitry.

B. System Identification and Modeling

This section presents the procedure undertaken to model the piezoelectric tube scanner used in this work. The model of the device can be identified from the frequency response functions (FRFs) obtained from the apparatus. A bandlimited swept sine input of amplitude 200 mVpk, within the frequency range of 1 Hz to 10 kHz, was used to excite the system. The following FRFs were obtained using a HP 35670 A dual channel spectrum analyzer

$$T_{px}(i\omega) = \frac{v_{px}(i\omega)}{u_x(i\omega)}, \quad T_{py}(i\omega) = \frac{v_{py}(i\omega)}{u_y(i\omega)}$$  \hspace{1cm} (9)

and

$$T_{cx}(i\omega) = \frac{v_{cx}(i\omega)}{u_x(i\omega)}, \quad T_{cy}(i\omega) = \frac{v_{cy}(i\omega)}{u_y(i\omega)}$$  \hspace{1cm} (10)

where $u_x$ and $u_y$ are the input voltages applied to the high voltage amplifiers, $v_{px}$ and $v_{py}$ are the piezoelectric induced voltages, and $v_{cx}$ and $v_{cy}$ are the capacitive sensor voltages of the $x$- and $y$-axis, respectively. Fig. 11 shows the block diagram of the experimental setup used for obtaining the FRFs. The measured open-loop FRFs are plotted in Fig. 12. The measured FRFs were approximated by the following third-order LTI models:

$$\begin{bmatrix}
T_{px}(s) \\
T_{py}(s) \\
T_{cx}(s) \\
T_{cy}(s)
\end{bmatrix} \approx \frac{1}{\left(1 + \frac{2\sigma}{\omega_0} s + \frac{\sigma^2}{\omega_0^2}\right) \left(1 + \frac{\sigma}{\omega_0} s\right)} \begin{bmatrix}
0.0675 \\
0.0825 \\
0.42 \left(1 - 1.276 \times 10^{-5} s + 2.774 \times 10^{-8} s^2\right) \left(1 + \frac{\sigma}{\omega_0} s\right) \\
0.4275 \left(1 - 1.276 \times 10^{-5} s + 2.774 \times 10^{-8} s^2\right) \left(1 + \frac{\sigma}{\omega_0} s\right)
\end{bmatrix}$$  \hspace{1cm} (11)
where \( \omega_0 = 3210.7 \, \text{rad/s} \) and \( \zeta = 0.016 \). As shown in Fig. 12, the LTI model roughly approximates the frequency response of the system within the bandwidth of interest. The real pole \( s = -2 \) was included to cope with the time response of the system to constant inputs in a long run. Fig. 13 shows normalized step responses of the system obtained by individually applying positive step inputs with amplitudes 2 V at \( u_x \) and \( u_y \) and then dividing the measured outputs by 2 V, where the insert in each graph shows a clear view of the response at the initial moments. The step responses of the individual channels of the LTI model, shown in Fig. 13, show that the time response of the LTI model is roughly consistent with the experimental results. The undershoots of the piezoelectric output voltages at the starting moments demonstrates the non-minimum-phase behavior of the system, which justifies the right-half plane zeros in the LTI models for \( T_{px} \) and \( T_{py} \).

### C. Damping Loop

Our purpose in this section is to damp the frequency response of the scanner without limiting the bandwidth much less than the first resonance frequency. The piezoelectric strain-induced voltages, which have less noise than capacitive sensors, were used as feedback signals to damp the first resonant peak of each axis of the tube scanner. The structure of the damping loop is shown in Fig. 14. To design the controller \( C_{x/y} \) for each axis, we use affine parametrization method [51]. Using the transfer functions obtained in Section VI-B for the piezoelectric outputs as the plant and considering all poles of the plant undesirable, affine parametrization method leads to the following poles assignment equation:

\[
\bar{L}(s)A_0(s) + \bar{P}(s)B_0(s) = \tilde{E}(s)
\]

where \( B_0(s) \) and \( A_0(s) \) are numerator and denominator polynomials of the plant transfer function, respectively, \( \tilde{E}(s) \) is the desired characteristic polynomial after closing the damping loop, and \( \bar{P} \) and \( \bar{L} \) are the numerator and denominator polynomials of the damping compensator, respectively. Since \( A_0 \) and \( B_0 \) are of order three, selecting degree of two for the compensator polynomials \( \bar{P} \) and \( \bar{L} \) and degree of five for the desired polynomial \( \tilde{E} \) lead to a unique solution for compensator. The desired closed-loop poles of the damping loops for \( x \) and \( y \)-axes, which determine \( \tilde{E}(s) \), were selected as

\[
x\text{-axis: } -1000 \pm 1500i, -1500 \pm 2000i, -2.3
\]

\[
y\text{-axis: } -1000 \pm 4000i, -1500 \pm 2000i, -2.15
\]

To keep an acceptable stability margin, we had to keep one of the desired closed-loop poles around the slow open-loop pole of the plant at \( s = -2 \). For \( x \)-axis, which needs to track a fast triangular waveform, the selected desired imaginary poles have more damping in comparison with the \( y \)-axis, which should track a less steep ramp. Because of unmodeled dynamics, it is desirable for the compensator transfer functions to roll off at high frequencies to avoid spillover effect. Hence, after calculating the compensator transfer functions, we dropped the \( s^2 \) term in the numerator of \( C_x(s) \) and \( s^2 \) and \( s \) terms in the numerator of \( C_y(s) \).
to zero. With these changes, the gain margin of 16.5 dB and the closed-loop poles changed very little for $x$-axis. For $y$-axis they moved to $-801 \pm 3245 i$, $-1825 \pm 2227 i$ and $-2.15$, which are still around the original ones, however, the gain margin changed to 23 dB (from 15 dB). The resulting $x$ and $y$ damping compensators are as follows:

$$C_x(s) = \frac{-0.9603(1 + 0.00114s)}{1 + 0.00100s + 4.024 \times 10^{-7}s^2 - 0.4222}$$

$$C_y(s) = \frac{1 + 0.000533s + 1.035 \times 10^{-7}s^2}{1 + 0.000533s + 1.035 \times 10^{-7}s^2}.$$  

The negative signs in the compensators show their consistency with the positive position feedback (PPF) method mentioned in [23]. Using the experimental frequency responses obtained in Section VI-B, the frequency responses of $x$ and $y$ displacement outputs after closing the damping loops along with the open-loop responses are shown in Fig. 15. Clearly, the first resonance of each axis has been damped without considerably limiting the bandwidth.

The damped $y$-axis is controlled by an ordinary integral control as shown in Fig. 16, where compensator

$$K_y(s) = \frac{1500}{s}$$

provides gain margin 8.2 dB and phase margin 86°. The $y$-axis reference signal $r_y$ is a ramp signal whose slope is 512 times less than the slope of the $x$-axis triangular reference. The $x$-axis controllers and the triangular reference signal are as in Section V. The overall noise transfer function $T_{x|n}(s)$ for the $x$-axis controller has a bandwidth of 21 Hz as before. A calibration grating (MikroMasch TGQ1) with a 3 $\mu$m period, 1.5 $\mu$m square side and 20 nm height was used for imaging. A contact mode ContAl cantilever probe with a resonance frequency of 13 kHz was used to perform the scan. To evaluate the scanning performance of the controllers, a 9.8 Hz triangular reference signal was applied to the $x$-axis and the aforementioned synchronized ramp signal was applied to the $y$-axis of the piezoelectric tube scanner to generate a 10 $\mu$m×10 $\mu$m image (with 256×256 scan lines). Fig. 17(a) shows the scanned image and the tracking performance of the $x$-axis displacement with signal transformation of the piezoelectric tube scanner. The RMS error of the tracking signal is 80 nm.

### D. Tracking Performance and Noise

The resolution of the piezoelectric tube is often governed by the sensor noise due to the noise being fed back to the actuator in closed loop systems. This makes open-loop architecture a more attractive solution than that of closed-loop. However, open-loop devices are sensitive to nonlinear effects such as drift and creep. These effects deteriorate the tracking performance and subsequently degrade the image quality generated by the devices.

The signal transformation method presented in this paper ensures that the noise content of the controlled $x$-position signal $x$, in Fig. 4, is low. To estimate the noise content of the $x$-axis
displacement, the capacitive sensor output was first recorded as the noise signal $n_x$ while the piezoelectric tube remained stationary. Response of noise transfer function $T_{nm}(s)$ to the recorded noise signal was then obtained by simulation as a measure of noise projected into the actual $x$-position and has the histogram shown in Fig. 17(a). The standard deviations of the sensor noise $n_x$ and the projected noise are 3.85 and 0.13 nm, respectively. Fig. 18 shows how the inverse mapping $\Phi^{-1}$ converts the smooth signal at the output of the double integrator compensator to a suitable non-smooth actuation signal for the robustified plant during the experiment.

To evaluate efficacy of signal transformation, we now consider an ordinary feedback system with the same level of projected noise for comparison purposes. To do this, we use the control structure shown in Fig. 17(b), which uses a double integrator compensator as $K_{ii} = (250s + 2500)/s^2$, which was adjusted to provide the same standard deviation of 0.13 nm for the projected noise. With a the triangular reference signal applied at $x_d$ in Fig. 17(b), the resulting steady-state tracking performance of the $x$-axis is as shown in Fig. 17(b), where the root-mean-square (RMS) tracking error is considerably more than that of the signal transformation method. This tracking error is mostly contributed by the low closed-loop bandwidth of the system.

Alternatively, if in the latter system, which does not include signal transformation blocks, we increase the integrator gain of the $x$-channel to 1430 to keep the RMS value of the resulting steady-state tracking error equal to that of the system that includes signal transformation blocks, the standard deviation of the projected noise will increase to 0.36 nm, as shown in Fig. 17(c), which is almost three times more than that obtained with signal transformation. Thus, signal transformation with the proposed robustification loop provides better tracking performance, while keeping...
Signal transformation method can improve the steady-state error in tracking of a periodic triangular desired signal while limiting the closed-loop control bandwidth to minimize the impact of measurement noise on positioning accuracy. Robustness

VII. CONCLUSION

Signal transformation method can improve the steady-state error in tracking of a periodic triangular desired signal while limiting the closed-loop control bandwidth to minimize the impact of measurement noise on positioning accuracy. Robustness issue of signal transformation method against dc gain variations and output disturbance was demonstrated and a method was offered to solve this problem. Effectiveness of the proposed method was examined by simulations and experiments on a piezoelectric tube AFM scanner.

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